

**Notice of References Cited**

Application/Control No.

10/573,198

Applicant(s)/Patent Under  
Reexamination  
TANAKA ET AL.

Examiner

THIEM PHAN

Art Unit

3729

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,400,639	08-1983	Kobayashi et al.	310/215
*	B	US-3,909,648	09-1975	Clark, Norman D.	310/260
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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